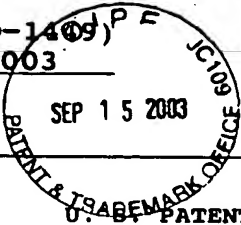


Sheet 1 of 1

Atty. Docket No.  
4293Serial No.:  
10/017,983FIFTH  
LIST OF REFERENCES CITED BY  
APPLICANT(REVISED FORM PTO-1409)  
DATED: Sept mber 10, 2003

Applicant: Masaaki HARASAWA et al.

U.S. Filing Date:  
December 13, 2001Art Unit:  
2839

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	Fil. Date

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.							DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
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MCZ	AL	53-	1	6	3	5	8	2	05/1952	Japan (Utility Model)	-	-	x-Partial trans.	
	AM	62	-	1	2	2	8	1	01/1987	Japan (Utility Model)	-	-	x-Partial trans.	
	AN	4-	1	3	5	1	7	6	12/1992	Japan (Utility Model)	-	-	x-Abst.	
	AO		6	-	7	1	7	7	01/1994	Japan (Utility Model)	-	-	x-Abst.	
	AP	6	-	2	9	0	6	4	04/1994	Japan (Utility Model)	-	-	x-Abst.	
	AQ	6	-	3	1	0	9	4	04/1994	Japan (Utility Model)	-	-	x-Abst.	
	AR	06-	2	1	5	8	3	3	08/1994	Japan	-	-	x-Abst.	

## OTHER DOCUMENTS

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Sheet 1 of 1

Atty. Docket No.  
4293Serial No.:  
10/017,983SIXTH  
LIST OF REFERENCES CITED BY  
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(REVISED FORM PTO-1449)

DATED: December 17, 2003

Applicant: Masaaki HARASAWA et al.

U.S. Filing Date:  
December 13, 2001Art Unit:  
2839

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*EXAMINER INITIAL		DOCUMENT NO.							DATE	NAME	Cl.	Sub- Cl.	Fil. Date
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	AZ	5	6	0	5	1	5	0	02/1997	Radons et al.	-128	-630	-
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↓	AF2	6	5	8	9	0	8	2	07/2003	Harasawa et al.	-439	-752	-

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													Yes	No

## OTHER DOCUMENTS

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